
Micromagnetic Simulation of the Pinning and Depinning Process in Permanent Magnets

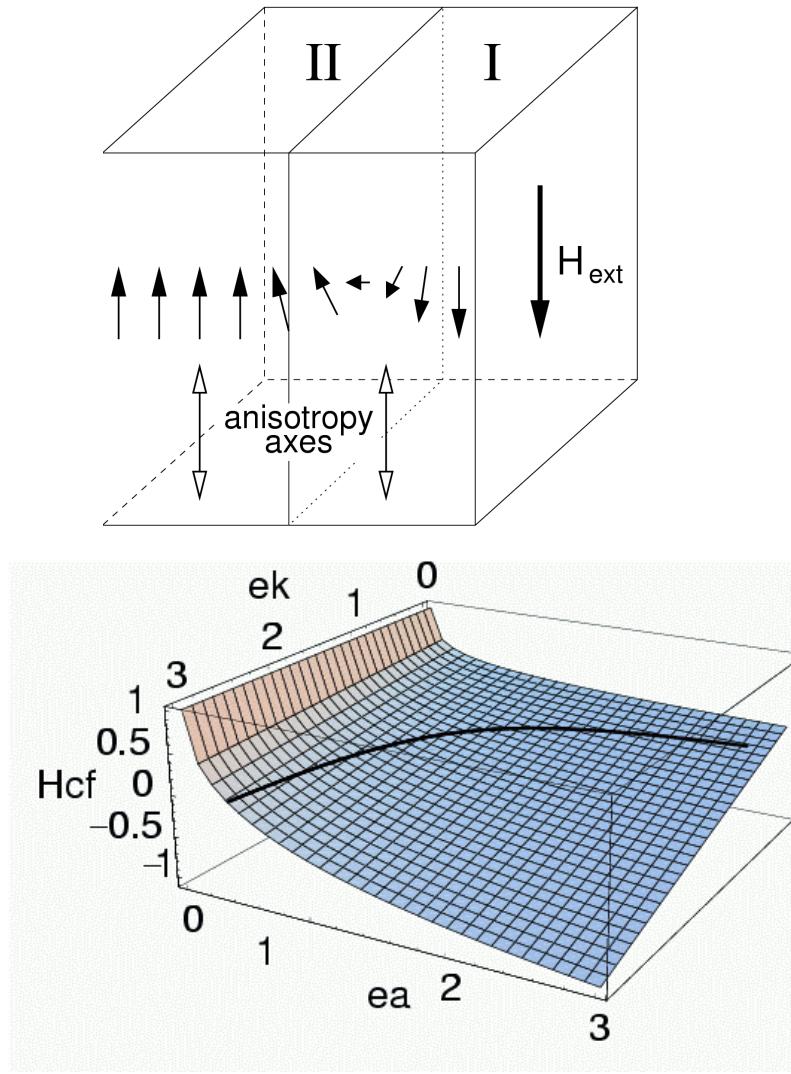
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Outline

- Pinning on a planar interface
- Comparison with an analytical model
- Pinning on the intercellular phase
- Attractive and repulsive pinning
- Pinning on the cell structure
- Summary

Pinning on a planar interface

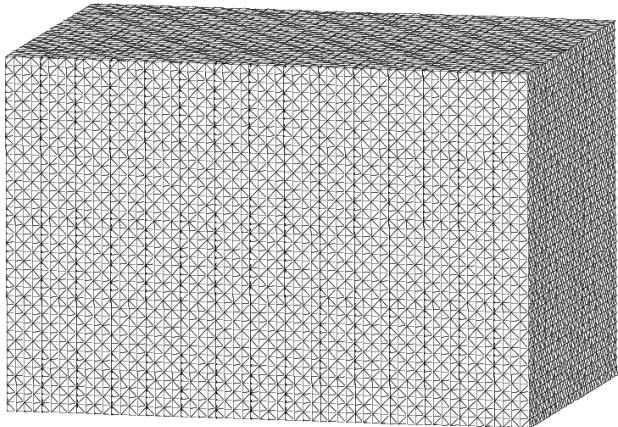


- Perfect planar interface
- Step like change in material parameters
- Strayfield omitted
- Analytical 1D model
Kronmüller, Goll, Physica B 319 (2002) 122-126
- Step-like or smooth transition of material parameters
E. Della Torre, C. M. Perlov, J. Appl. Phys. 69 (1991) 4569-4598.

$$\varepsilon_A = \frac{A^I}{A^{II}}, \quad \varepsilon_J = \frac{J_s^I}{J_s^{II}}, \quad \varepsilon_K = \frac{K_1^I}{K_1^{II}}$$

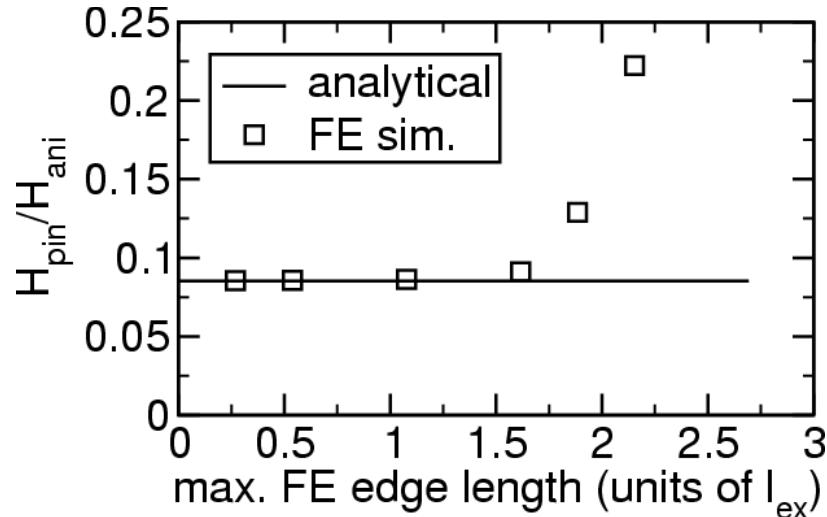
$$H_c = \frac{2K_1^{II}}{J_s^{II}} \frac{1 - \varepsilon_K \varepsilon_A}{(1 + \sqrt{\varepsilon_A \varepsilon_J})^2}$$

Calibration of the FE simulation



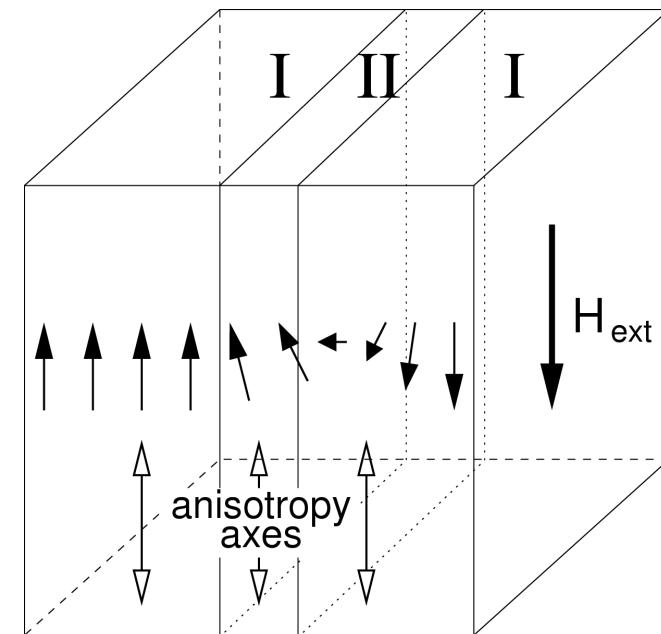
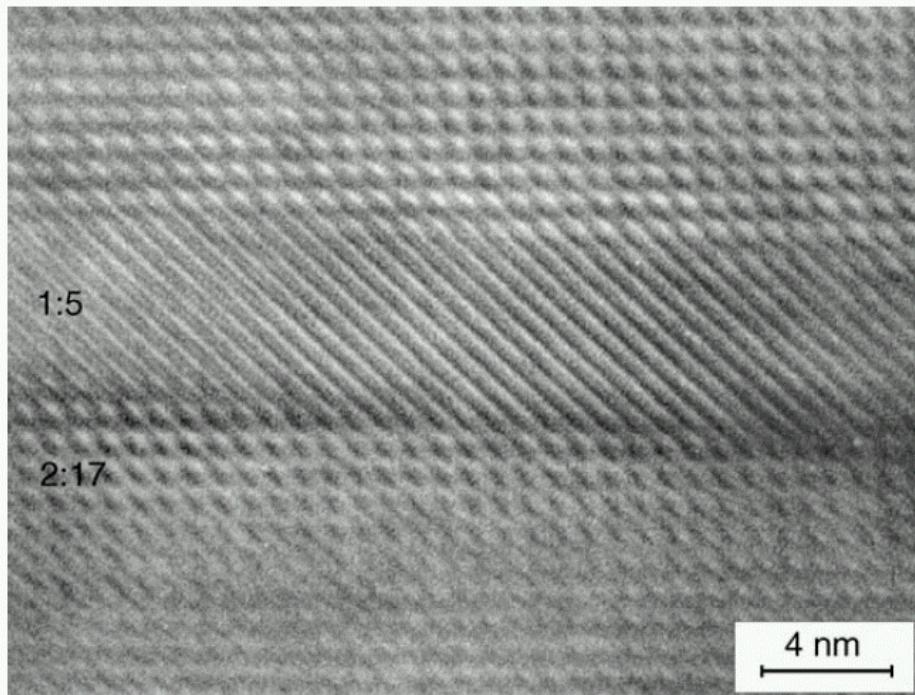
FE model of size 10x10x15
Discretized with tetrahedral finite elements

Nodes	102541
Elements	480000
Edge _{min}	0.25
Edge _{max}	0.35



	„2:17“ cells	Boundary phase
J_s (T)	1.3	0.8
A (pJ/m)	14.0	14.0
K_1 (MJ/m ³)	5.0	9.0
L_{ex} (nm)	1.7	1.3
d_{Bloch} (nm)	5.3	3.9
H_{ani} (kA/m)	7692	22500

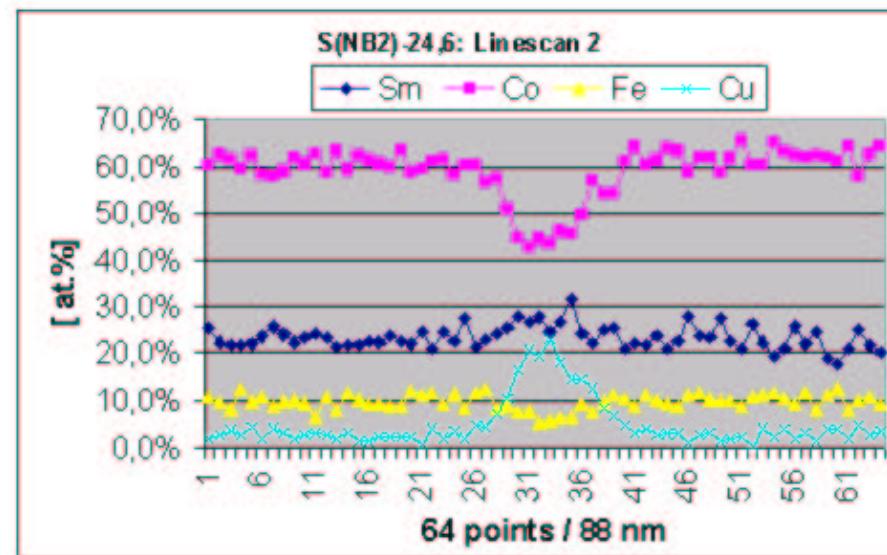
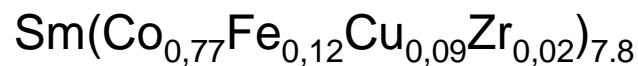
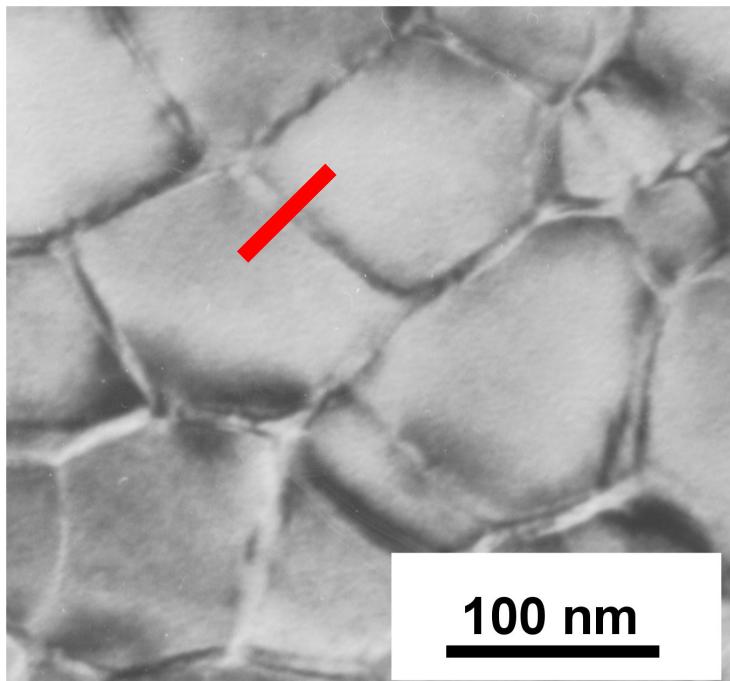
Pinning on the intercellular phase



HRTEM of a $\text{Sm}(\text{Co}_{\text{bal}}\text{Cu}_{0.07}\text{Fe}_{0.22}\text{Zr}_{0.04})_{7.4}$ magnet
H. Kronmüller, D. Goll, Physica B 319 (2002) 122-126

Nanoanalytical investigations

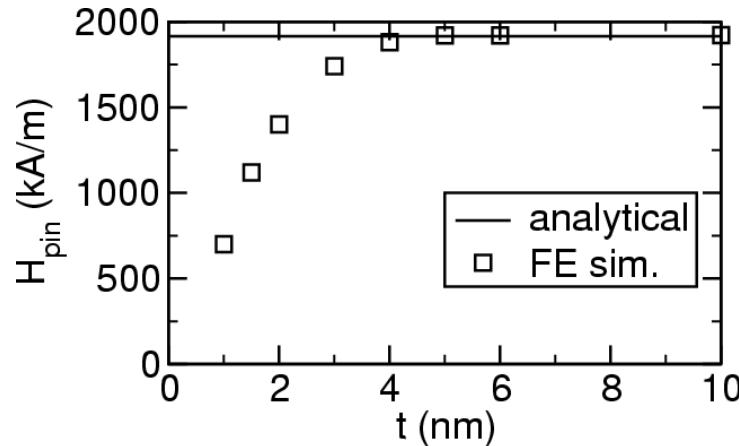
Analysis of the elemental distributions across the precipitates on a nanometer scale; requires field emission gun TE



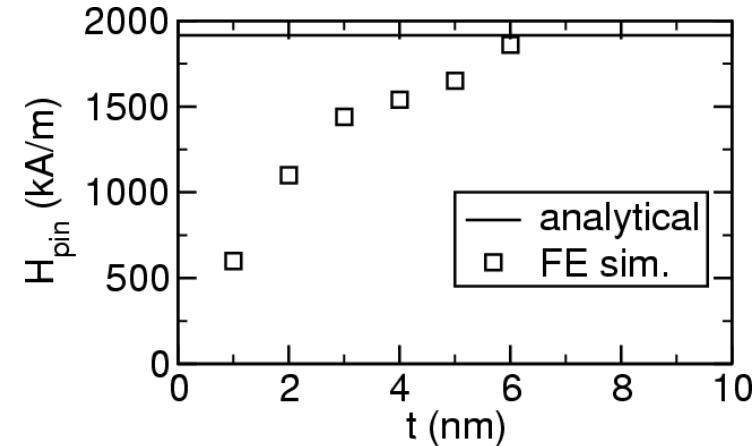
Cell boundaries: high Cu, Sm

Cell matrix: high Fe, Co

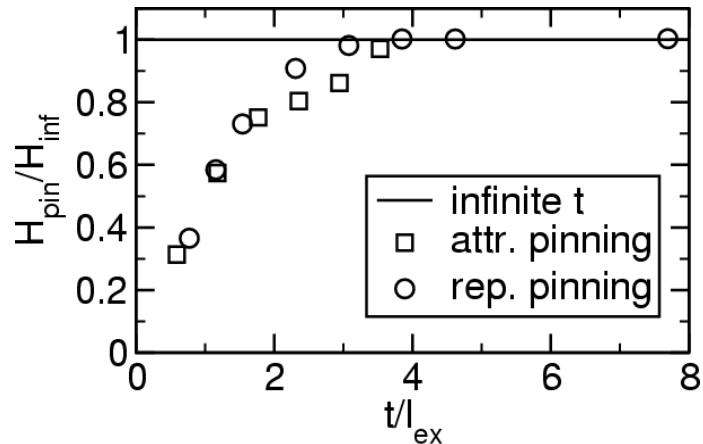
Pinning fields



Repulsive pinning



Attractive pinning

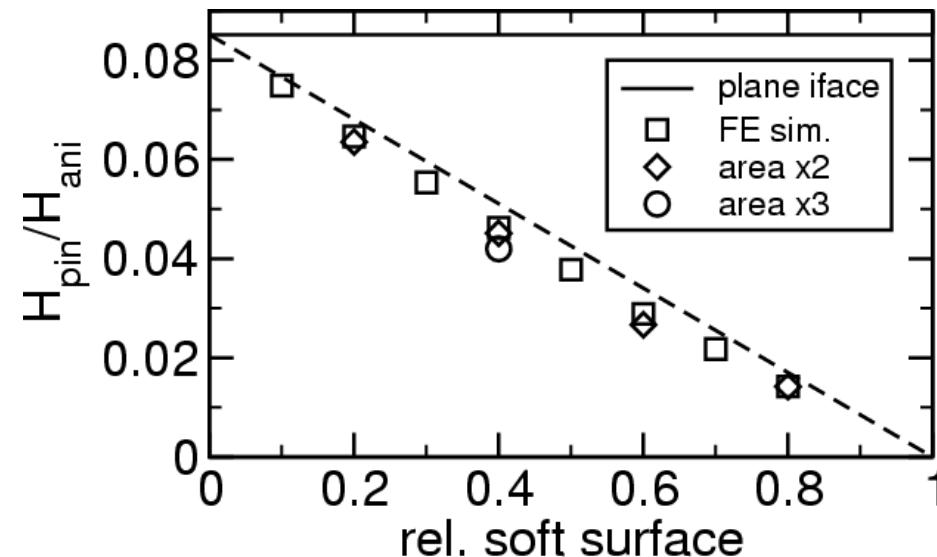
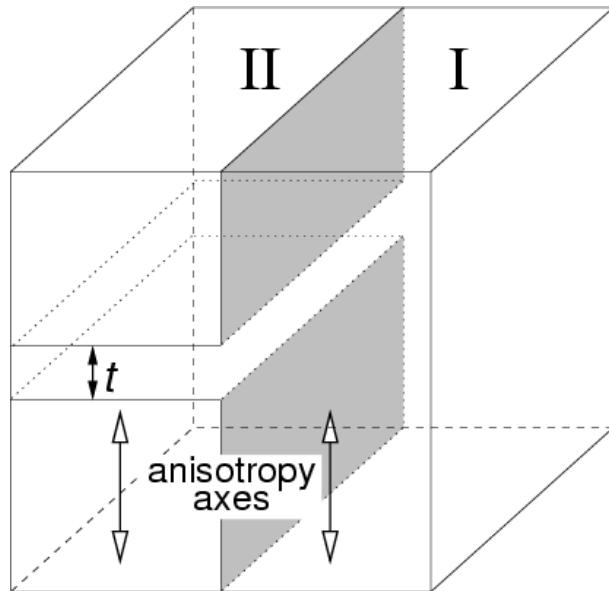


$$H_{\text{inf}} = 1916 \text{ kA/m}$$

t scaled with l_{ex} of the intercellular phase

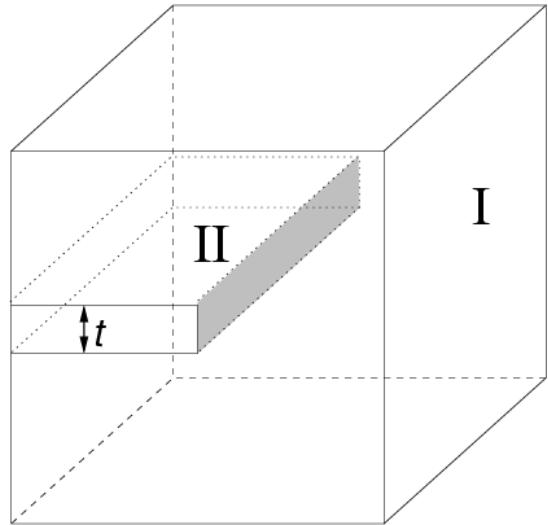
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Pinning on the cell structure

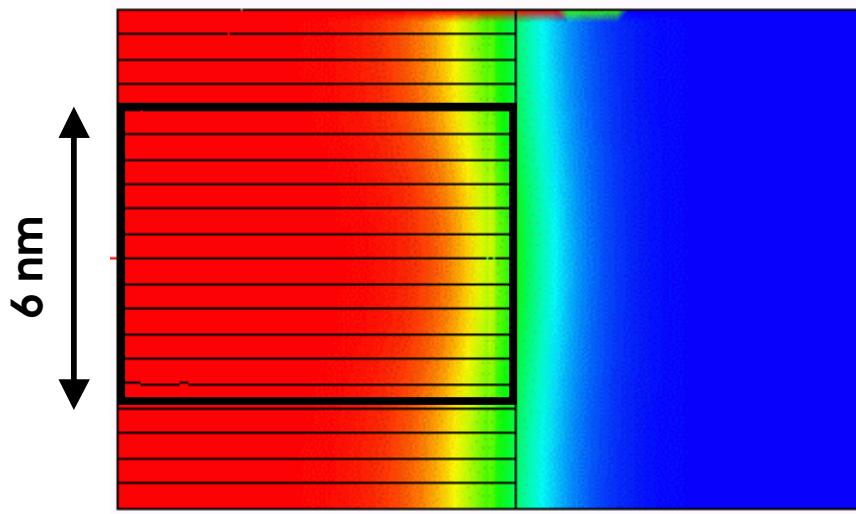


Pinning field depends on the surface ratio between hard and soft areas (i.e. on ratio of cross section between cells and cell boundary phase)

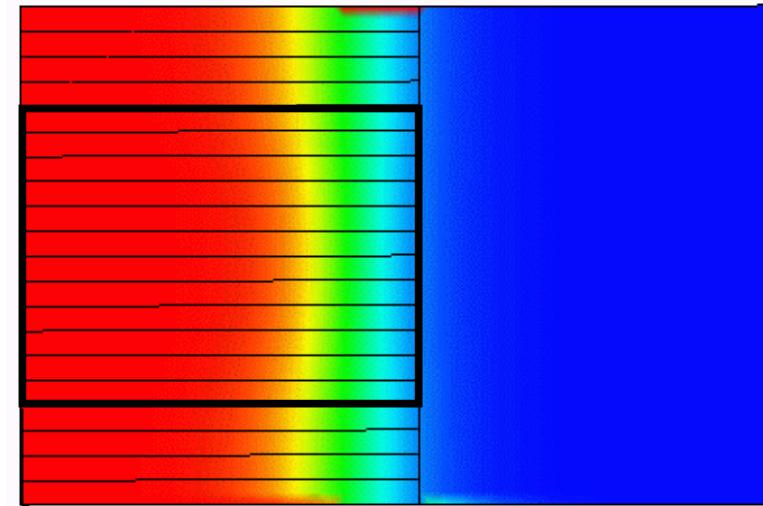
Magnetization distribution



- Dynamic micromagnetic simulation: integration of Landau-Lifshitz-Gilbert equation
- Competition between Zeeman and domain wall energy
- Domain wall moves into the hard defect

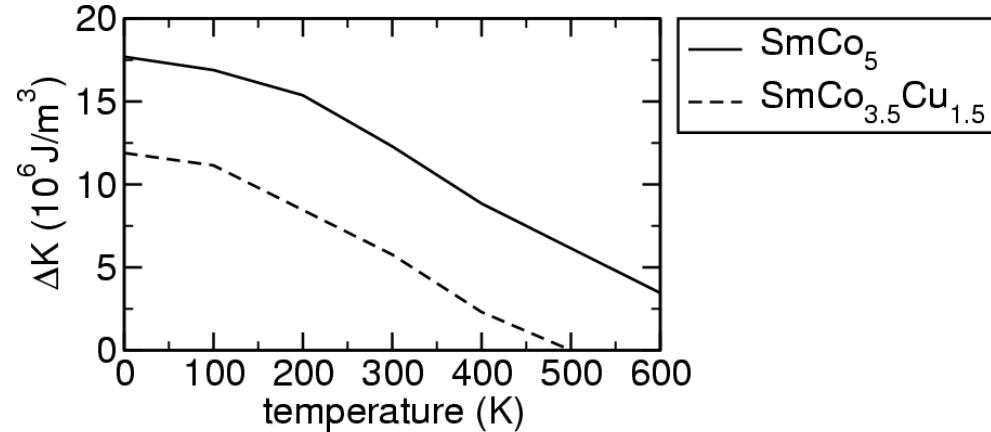
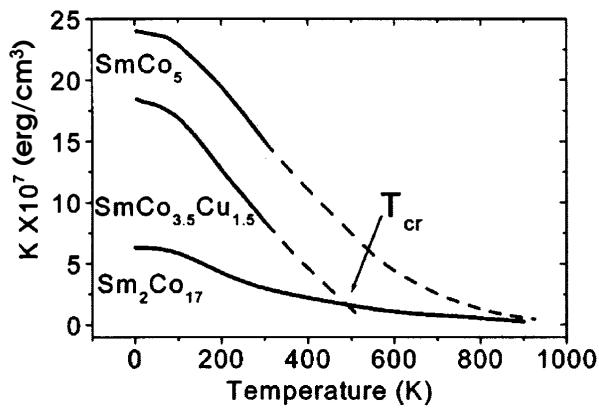


Last stable configuration

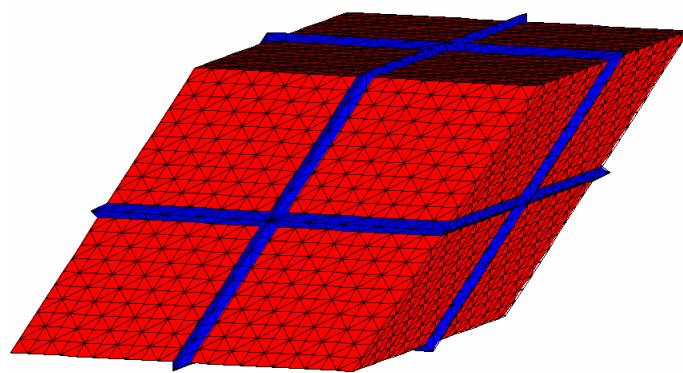


Domain wall breaks free

Temp. dependent pinning fields

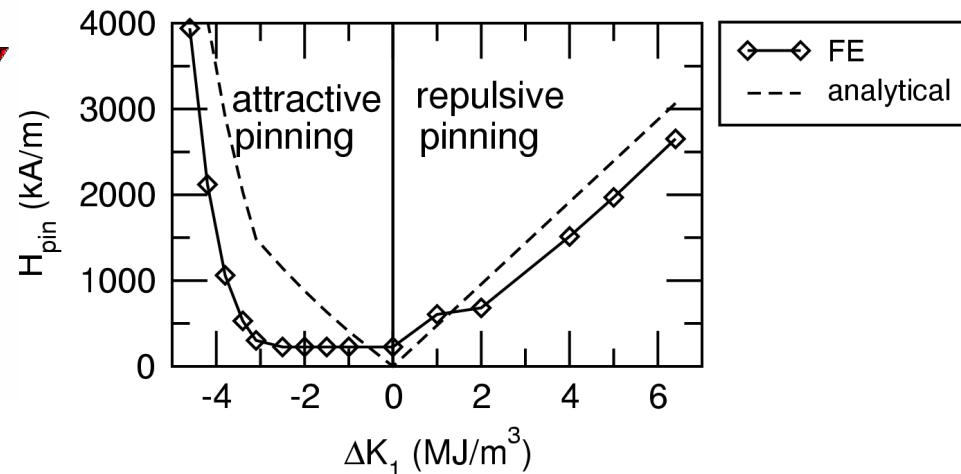


W. Tang, A. M. Gabay, Y. Zhang, G. C. Hadjipanayis,
H. Kronmüller, IEEE Trans. Magn. 37 (2001) 2515-2517



Cell size: 125 nm

Thickness of intercellular phase: 5 nm



Summary

- Simple comparison with 1D analytical result
- Exchange decoupling important
- Anisotropy gives linear contribution to coercivity
- Thickness of the intercellular phase has to be larger than the domain wall width to have maximum pinning effect
- Precipitation structure reduces the pinning field
- Optimum properties for large cells